March 1999

# **FAIRCHILD** SEMICONDUCTOR

# FDR838P P-Channel 2.5V Specified PowerTrench<sup>™</sup> MOSFET

### **General Description**

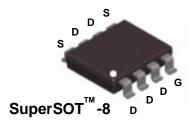
These P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

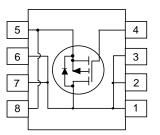
## Applications

- Load switch
- Motor driving
- Power Management

## Features

- Low gate charge (30nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- Small footprint (38% smaller than a standard SO-8); low profile package (1 mm thick); power handling capability similar to SO-8.





# Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
/ <sub>GSS</sub>	Gate-Source Voltage		<u>+</u> 8	V
D	Drain Current - Continuous	(Note 1a)	-8	А
	- Pulsed		-50	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	1.8	W
		(Note 1b)	1.0	
		(Note 1c)	0.9	
Г <sub>J</sub> , Т <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	∘C

# **Thermal Characteristics**

R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	70	°C/W
$R_{\theta^{JC}}$	Thermal Resistance, Junction-to-Case	(Note 1)	20	°C/W

## Package Outlines and Ordering Information

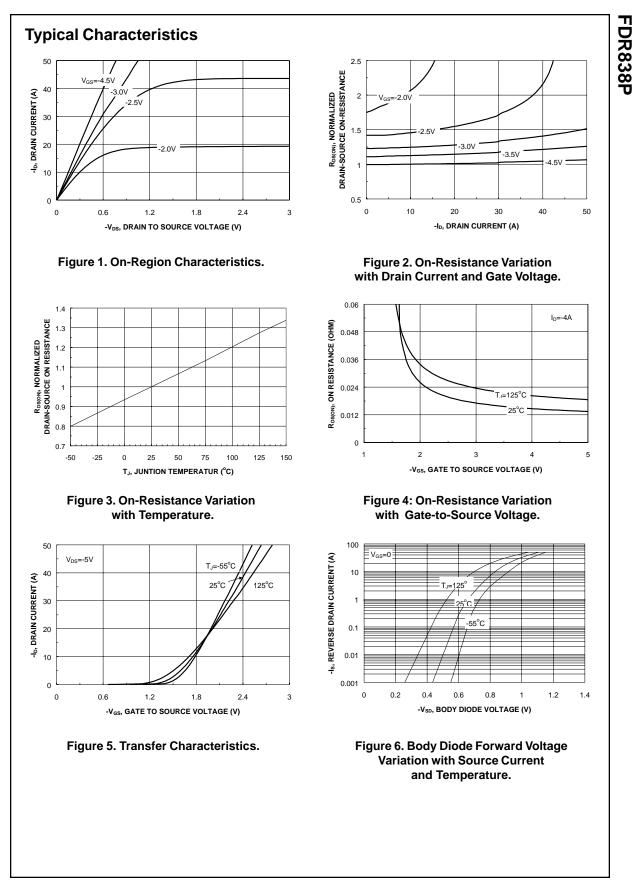
Device Marking	Device	Reel Size	Tape Width	Quantity
.838P	FDR838P	13"	12mm	3000 units

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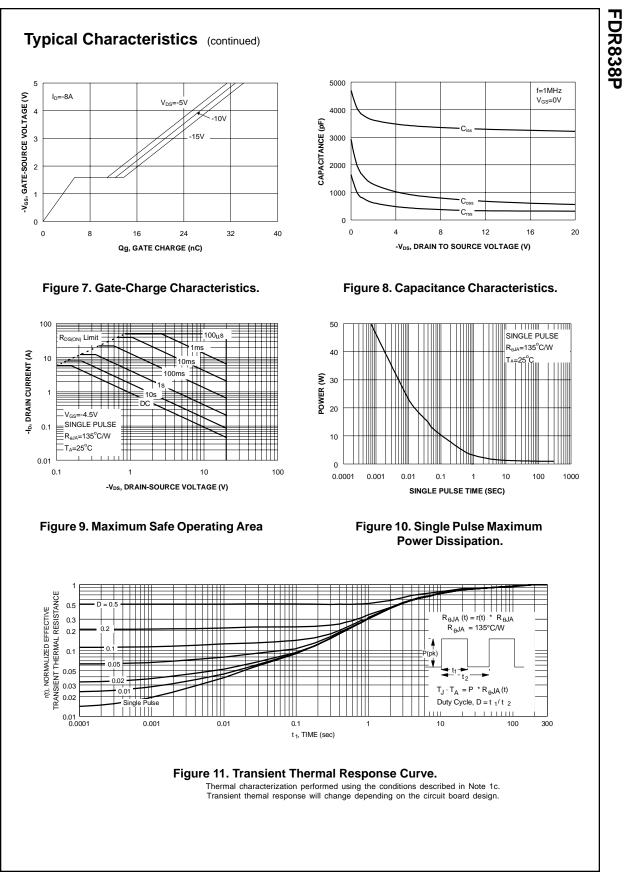
**Electrical Characteristics**  $T_A = 25^{\circ}C$  unless otherwise noted Symbol Min Max Units Parameter **Test Conditions** Typ **Off Characteristics** Drain-Source Breakdown Voltage  $V_{GS} = 0 \text{ V}, I_D = -250 \mu \text{A}$ V -20 **BV**<sub>DSS</sub>  $I_D$ = -250  $\mu$ A, Referenced to 25°C mV/∘C Breakdown Voltage Temperature -18 Coefficient  $\Delta T_J$  $V_{\text{DS}} = -16 \text{ V}, \text{ } V_{\text{GS}} = 0 \text{ V}$ Zero Gate Voltage Drain Current -1 μΑ IDSS Gate-Body Leakage Current, Forward  $V_{\text{GS}}=8~\text{V},~V_{\text{DS}}=0~\text{V}$ 100 nA I<sub>GSSF</sub>  $V_{GS} = -8 V, V_{DS} = 0 V$ Gate-Body Leakage Current, Reverse -100 nA I<sub>GSSR</sub> On Characteristics (Note 2) Gate Threshold Voltage -0.4 -0.85 -1.5 V  $V_{DS} = V_{GS}$ ,  $I_D = -250 \ \mu A$ V<sub>GS(th)</sub>  $I_{D}$  = -250  $\mu$ A, Referenced to 25°C mV/∘C AVGS(th) Gate Threshold Voltage 3 **Temperature Coefficient**  $\Delta T_J$  $V_{GS} = -4.5 \text{ V}, I_{D} = -8 \text{ A}$  $R_{\text{DS(on)}}$ Static Drain-Source 0.014 0.017 Ω **On-Resistance**  $V_{GS} = -4.5V, I_D = -8 A, T_J = 125 \circ C$ 0.020 0.026  $V_{GS} = -2.5 \text{ V}, I_D = -7.0 \text{ A}$ 0.020 0.024 **On-State Drain Current**  $V_{GS} = -4.5 V, V_{DS} = -5 V$ -50 А I<sub>D(on)</sub> **g**<sub>FS</sub> Forward Transconductance  $V_{\text{DS}} = \textbf{-5} \ V, \ I_{\text{D}} = \textbf{-8} \ A$ 28 S **Dynamic Characteristics** Input Capacitance  $V_{DS} = -10 V, V_{GS} = 0 V,$ 3300 pF Ciss f = 1.0 MHz **Output Capacitance**  $C_{\text{oss}}$ 730 pF pF Crss **Reverse Transfer Capacitance** 350 Switching Characteristics (Note 2)  $V_{DD} = -10 V$ ,  $I_{D} = -1 A$ , Turn-On Delay Time 14 25 ns t<sub>d(on)</sub>  $V_{GS}$  = -4.5 V,  $R_{GEN}$  = 6  $\Omega$ Turn-On Rise Time 20 32 ns tr Turn-Off Delay Time 150 110 t<sub>d(off)</sub> ns Turn-Off Fall Time 60 90 tf ns  $V_{DS} = -10 V$ ,  $I_{D} = -8 A$ , Qq **Total Gate Charge** 30 45 nC  $V_{GS} = -4.5 V$ Gate-Source Charge 5 nC Q<sub>gs</sub> Gate-Drain Charge 9 nC  $Q_{qd}$ **Drain-Source Diode Characteristics and Maximum Ratings** Maximum Continuous Drain-Source Diode Forward Current -1.5 A ls Drain-Source Diode Forward Voltage  $V_{GS} = 0 V$ ,  $I_S = -1.5 A$  (Note 2) -0.7 -1.2 V  $V_{\text{SD}}$ 1. ReJA is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain Pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design. a) 70° C/W when mounted on a ЛЦ b) 125° C/W when mounted on c) 135° C/W when mounted on 1.0 in<sup>2</sup> pad of 2 oz. copper. a 0.026 in<sup>2</sup> pad of 2oz. copper. a minimum pad.

Scale 1 : 1 on letter size paper 2. Pulse Test: Pulse Width  $\leq$  300  $\mu s,$  Duty Cycle  $\leq$  2.0%

FDR838P



FDR838P, Rev. C



FDR838P, Rev. C

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